I Introduction

• Pop. mean is $\mu = \omega_1 \mu_1 + \cdots + \omega_k \mu_k$ & pop. var. Std. nor. distr. N(0,1) has cum. distr. fn. is $\sigma^2 = \overline{\sigma^2} + \sum_{j=1}^{\infty} \omega_j (\mu_j - \mu)^2$ $\phi(z) = \frac{1}{\sqrt{2\pi}} \int_{-\infty}^{z} e^{-y^2/2} dy$

• If we pick at random one element from the pop., then its value x is a realisation of a random

var. X whose distr. is the pop. distr. • Pop. mean $\mu = E(X) = \frac{1}{N} \sum_{i=1}^{N} x_i$ & pop. std. dev.

II Random sampling

$\sigma = \sqrt{Var(X)}$ & pop.tot $\tau = \sum_{i} x_i = N\mu$

• Prob. distr. curve depends on estimating μ &

• S.O.R produces a simple random sample.
• S.W.R produces an I.I.D sample.
• Point estimation
• Sampling distribution has mean
$$\mu_{\hat{\Theta}} = E(\hat{\Theta})$$

• Sampling distribution has mean
$$\mu_{\hat{\Theta}} =$$
 and var. $\sigma_{\hat{\Theta}}^2 = E(\hat{\Theta} - \mu_{\hat{\Theta}})^2$.

2. Sample mean and sample variance • Sample mean $\bar{x} = \frac{1}{n} \sum_{i=1}^{n} x_i$ & sample std. dev.

$s^2 = \frac{1}{n-1} \sum_{i=1}^{n} (x_i - \bar{x})^2 = \frac{n}{n-1} (\overline{x^2} - \overline{x}^2)$ Independent and identically distributed(I.I.D) sample: sample mean \bar{x} and sample var s^2

are unbiased estimators for the pop. mean μ

and var $\sigma^2 E(\bar{X}) = \mu, Var(\bar{X}) = \frac{\sigma^2}{n}, E(S^2) =$

 σ^2 , $Var(S^2) = \frac{\sigma^4}{n} (E(\frac{X-\mu}{\sigma})^4 - \frac{n-3}{n-1})$ • Dichotomous case: sample mean turns into a sample proportion $\hat{p} = \hat{x}$ giving an unbiased estimate of p $\mu = p, \sigma^2 = p(1-p)$ • Estimated standard errors for the sample mean

and proportion $s_{\bar{x}} = \frac{s}{\sqrt{n}} \& s_{\hat{p}} = \sqrt{\frac{\hat{p}(1-\hat{p})}{n-1}}$ • Simple random sampling(S.R.S): sample mean

\bar{x} is an unbiased estimate for pop. mean μ & sample var. s^2 is a biased estimate of σ^2 $E(S^2) = \sigma^2 \frac{N}{N-1} \& Var(\bar{X}) = \frac{\sigma^2}{n} (1 - \frac{n-1}{N-1})$. Unbiased estimate of $Var(\bar{X})$ is $s_{\bar{x}}^2 = \frac{s^2}{n}(1 - \frac{n}{N})$

• Sampling without replacement(S.O.R): estimated standard errors $s_{\bar{x}} = \frac{s}{\sqrt{n}} \sqrt{1 - \frac{n}{N}}$ & 3. Approximate confidence intervals

• By the Central Limit Theorem, the sample

mean distr. is approx. normal $\bar{X} \approx N(\mu, \frac{\sigma^2}{n})$ in that for large sample sizes n, we have $P(|\frac{X-\mu}{\sigma_{\bar{X}}}| > z) \approx 2(1-\phi(z))$. Since $S_{\bar{X}} \approx \sigma_{\bar{X}}$, we have $P(\bar{X} - zS_{\bar{X}} < \mu < \bar{X} + zS_{\bar{X}}) =$ $P(|\frac{X-\mu}{\sigma_x}| > z) \approx 2(1-\phi(z))$. This yields

the formula of $100(1-\alpha)\%$ 2-sided c.i for $\mu \& p: I_{\mu} = \bar{x} \pm z_{\alpha/2} s_{\bar{x}}, I_{p} = \hat{p} \pm z_{\alpha/2} s_{\hat{p}}.$

• $100(1-\alpha)\%$ c.i for μ means $100(1-\alpha)\%$ are expected to cover the true value of μ . Higher the confidence level, the wider is confidence interval. Larger the sample, the narrower is confidence interval.

4. Stratified random sampling
• Strat. prop. for each strat. j, j=1,···,k is
$$\omega_j = \frac{N_j}{N}$$

s.t. $\omega_1 + \cdots + \omega_k = 1$

• Stratified sample mean is $\overline{x}_s = \omega_1 \overline{x}_1 + \cdots +$

size n_i for each strat. • Var. of \overline{X}_s is $Var(\overline{X}_s) = \sigma_{\overline{X}_s}^2 = \frac{\omega_1^2 \sigma_1^2}{n_1} + \dots + \frac{\omega_k^2 \sigma_k^2}{n_k}$ • Example: exponential model- From $\mu = \frac{1}{4}$, we • Opt. alloc. is $n_i = \frac{n\omega_j\sigma_j}{\overline{\sigma}}$ where $\sigma_i = \text{sample}$ std. dev. of sample size n_i for each strat. j &

 $\omega_k \overline{x}_k$ where $\overline{x}_i = \text{est. of sample mean of sample}$

 $\overline{\sigma} = \omega_1 \sigma_1 + \dots + \omega_k \sigma_k$ & n=tot. sample size • Prop. alloc. is $\overline{n}_i = n\omega_i$ • Var. of est. of pop. mean obtd using s.r.s is $Var(\overline{X}) = \frac{\sigma^2}{n}$

• Var. of est. of pop. mean obtd using prop. alloc is $Var(\overline{X}_{sp}) = \frac{\overline{\sigma^2}}{n}$ where $\overline{\sigma^2} = \omega_1 \sigma_1^2 + \dots + \omega_k \sigma_k^2$ • Var. of est. of pop. mean obtd using opt. alloc. is $Var(\overline{X}_{so}) = \frac{\overline{\sigma}^2}{r}$ $\bullet \ Var(\overline{X}) \geq Var(\overline{X}_{sp}) \geq Var(\overline{X}_{so})$

III Parameter estimation

• Approx. c.i. $I_{\mu} = \overline{x}_s \pm z_{\alpha/2} s_{\overline{x}_s}$

1. Method of moments Suppose an iid-sample from a pop. distr. is cha-

pose we have the foll. formulas for the 1st and 2nd pop. moments: $E(X) = f(\theta_1, \theta_2)$, $E(X^2) =$ $g(\theta_1, \theta_2)$. M.O.M est. $(\tilde{\theta}_1, \tilde{\theta}_2)$ are found after replacing the pop. moments with the corr. sample moments, and solving the obtained eqns $\bar{x} =$ $f(\tilde{\theta}_1, \tilde{\theta}_2), \ \bar{x^2} = g(\tilde{\theta}_1, \tilde{\theta}_2)$. This approach is justi-

fied by the Law of Large Numbers $\frac{X_1 + \dots + X_n}{n} \to \mu$,

 $\frac{X_1^2 + \dots + X_n^2}{n} \to E(X^2), n \to \infty.$ • Geometric model- m.o.m est. for para. $\theta = p$ is $\bar{x} = \frac{1}{\bar{p}}$, approx. c.i. for p is $I_p = \frac{1}{\bar{x} \pm z_{\alpha/2} s_{\bar{x}}}$, obs. freq. given, exptd. freq.= $n(1-\tilde{p})^{j-1}\tilde{p}$ 2. Maximum likelihood estimation

• In a parametric setting, given a parameter value θ , the observed sample (x_1, \dots, x_n) is a realisation of the random vector (X_1, \dots, X_n) which has a certain joint distr. $f(y_1, \dots, y_n | \theta)$ as a fn. of possible values (y_1, \dots, y_n) . Fixing the

variables $(y_1, \dots, y_n) = (x_1, \dots, x_n)$ and allowing the parameter value θ to vary, we obtain the li-

kelihood fn. $L(\theta) = f(x_1, ... x_n | \hat{\theta})$. The maximum likelihood estimate $\hat{\theta}$ of θ is the value of θ that maximises $L(\theta)$. • Example: binomial model- n obs. $X \sim$ Bin(n,p). From $\mu = np$, m.o.m est. $\tilde{p} = \frac{x}{n}$ is the sample proportion. Likelihood fn.is $L(p) = {n \choose x} p^x (1-p)^{n-x}$. Log-likelihood function is $l(p) = \ln L(p)$. Then l'(p) = 0 gives MLE of pop. prop. is the sample prop. $\hat{p} = \frac{x}{n}$ 3. Sufficiency • Example: Bernoulli distr.-For 1 Ber. trial,

 $f(x) = P(X = x) = p^{x}(1-p)^{1-x}, x \in \{0,1\}$ and for n Ber. trials, $f(x_1, \dots, x_n | p) =$ $\Pi_{i-1}^n p^{x_i} (1-p)^{1-x_i} = p^{n\bar{x}} (1-p)^{n-n\bar{x}}$. Thus for Ber. model, no. of successes $t = x_1 + \dots + x_n = n\bar{x}$ is a suff. statistic whose distr. is $T \sim Bin(n, p)$. • Example: Normal distr.- Nor. distr. mo-

del $N(\mu, \sigma^2)$ has 2-D sufficient statistic $(t_1, t_2), t_1 = \sum_{i=1}^n x_i, t_2 = \sum_{i=1}^n x_i^2$ which follows from $L(\mu, \sigma) = \prod_{i=1}^{n} \frac{1}{\sqrt{\sigma}} e^{-\frac{(x_i - \mu)^2}{2\sigma^2}} =$

 $(1/\sigma^n(2\pi)^{n/2})e^{-rac{t_2-2\mu t_1+n\mu^2}{2\sigma^2}}$ 4. Large sample prop. of the m.l.e • Normal approx. $\hat{\Theta} \approx N(\theta, \frac{1}{nI(\theta)})$. Let

 $g(x,\theta) = \frac{\partial^2 \ln f(x|\theta)}{\partial \theta^2}$ & Fisher information $I(\theta) = -E[g(X, \theta)] = -\int g(x, \theta) f(x|\theta) dx$. Approx. $100(1-\alpha)\%$ c.i. $I_{\theta} = \hat{\theta} \pm z_{\frac{\alpha}{2}} \frac{1}{\sqrt{nI(\theta)}}$

find $\tilde{\theta} = \frac{1}{\bar{x}}$. Likelihood fn. $L(\theta) = \theta^n e^{-\theta(x_1 + \dots + x_n)}$. For exp. model, $t = x_1 + \cdots + x_n$ is a suff. statistic & M.L.E is $\hat{\theta} = \frac{1}{\bar{z}}$ 5. Gamma distribution • Den. fn of Gamma distr. is $f(x|\alpha,\lambda) =$ $\frac{1}{\Gamma(\alpha)}\lambda^{\alpha}x^{\alpha-1}e^{-\lambda x}$, $0 \le x < \infty$ where sha-

pe parameter $\alpha > 0$ and scale parameter significance level/type I error- $\alpha = P(T \in R|H_0)$ $> 0. (t_1, t_2) = (x_1 + \cdots + x_n, x_1 \cdots x_n)$ is specificity of the test- $1-\alpha = P(T \notin R|H_0)$, pair of sufficient statistics. Likelihood type II error- $\beta = P(T \notin R|H_1)$ fn. is $L(\alpha, \lambda) = \prod_{i=1}^{n} \frac{1}{\Gamma(\alpha)} \lambda^{\alpha} x_i^{\alpha-1} e^{-\lambda x_i}$. sensitivity or power-1 – $\beta = \tilde{P}(T \in R|H_1)$ Log likelihood of i.i.d sample is $l(\alpha, \lambda) =$ $\sum [\alpha \ln \lambda + (\alpha - 1) \ln x_i - \lambda x_i - \ln \Gamma(\alpha)]$ $= n\alpha \ln \lambda + (\alpha - 1) \sum_{i=1}^{n} \ln x_i - \lambda \sum_{i=1}^{n} x_i - n \ln \Gamma(\alpha).$

Partial der. are $\frac{\partial l}{\partial \alpha} = n \ln \lambda + \sum_{i=1}^{n} \ln x_i - n \frac{\Gamma'(\alpha)}{\Gamma(\alpha)}$ racterised by a pair of parameters (θ_1, θ_2) . Sup- $\frac{\partial l}{\partial \lambda} = \frac{n\alpha}{\lambda} - \sum_{i=1}^{n} x_{i}$. Setting these to 0, $\hat{\lambda} = \frac{\hat{\alpha}}{x}$, than the observed one, given that H_0 is true. For given α , reject H_0 , if p-value $\leq \alpha$, and do $n \ln \hat{\alpha} - n \ln \overline{x} + \sum_{i=1}^{n} \ln x_i - n \frac{\Gamma'(\hat{\alpha})}{\Gamma(\hat{\alpha})} = 0$. Eqns. cannot

by m.o.m est.

 $\hat{\mu} = \overline{X} = \frac{1}{n} \sum_{i=1}^{n} X_{i} \& \hat{\sigma}^{2} = \frac{1}{n} \sum_{i=1}^{n} X_{i}^{2} - \overline{X}^{2}$. If we could simulate from the true population distribution $Gam(\alpha, \lambda)$, then B samples of size n 2. Large-sample test for the proportion would generate B independent estimates $\hat{\alpha}_i$. Bin model X ~ Bin(n,p). sample prop. $\hat{p} = \frac{x}{n}$ Then the standard deviation of the sampling

distribution would give us the desired std. err. $s_{\hat{\alpha}} = \sqrt{\frac{1}{B} \sum_{j=1}^{L} (\hat{\alpha}_j - \overline{\alpha})^2}, \, \overline{\alpha} = \frac{1}{B} \sum_{j=1}^{D} \hat{\alpha}_j$ • Diff. betwn. parametric & nonparametric bootstrap- In parametric bootstrap, we have a known (assumed) distr. $l(\theta)$ with unknown

parameter θ . We estimate θ by $\hat{\theta}$ and draw samples from the distr. $l(\hat{\theta})$. In non-parametric bootstrap, we do not assume an underlying distr and instead resample from the set of original samples x_1, \dots, x_n . Bootstrap is a resampling technique used to study the sampling distribution of a parameter estimator. In the parametric bootstrap resampling is done from the given parametric distribution with the unknown parameters

replaced by their estimates obtained from the

underlying sample. In the non-parametric boot-

strap resampling is performed with replacement

6. Exact confidence intervals

• t-distribution: $\frac{\bar{X}-\mu}{S_{\bar{X}}} \sim t_{n-1}$ • Exact 100 $(1-\alpha)\%$ c.i. for mean: $I_{\mu} =$ $\bar{x} \pm t_{n-1}(\alpha/2)s_{\bar{x}}$

directly from the the underlying sample.

1. Statistical significance • A rule based on data for choosing between 2 mutually exclusive hypotheses

 $\left(\frac{(n-1)s^2}{\chi^2_{n-1}(\alpha/2)}, \frac{(n-1)s^2}{\chi^2_{n-1}(1-\alpha/2)}\right)$

• chi-squared distribution: $\frac{(n-1)S^2}{\sigma^2} \sim \chi^2_{n-1}$ • Exact 100 (1- α)% c.i. for var: I_{σ^2}

IV Hypothesis testing

null hypothesis H_0 : effect of interest is zero, alternative H_1 : effect of interest is not zero. A decision rule for hypotheses testing is based on a test statistic $t = t(x_1, \dots, x_n)$, a fn. of the data with distinct typical values under H_0 & H_1 . The task is to find an appropriately chosen rejection region R and reject H_0 in favor of H_1 if and only if $t \in R$. Four imp condn. prob.-

 In statistical hypothesis testing, a type I error is the rejection of a true null hypothesis (also known as a false positive outcome), while a type II error is the failure to reject a false null hypothesis (also known as a false negative • A significance level is a pre-decided limit for null distr. $T \sim^{H_0} t_{n-1}$ • C.I. method of hypotheses testing- at sig. level when we reject the null hypothesis. A p-valué is the probability of obtaining a test statistic value as extreme or more extreme α , rejection rule is $R = \{\mu_0 \notin I_{\mu}\}$. Reject H_0 :

not reject H_0 , if p-value $> \alpha$. Observe that the p-value depends on the data and therefore, is a realisation of a random variable P. The source be solved in closed form and \therefore we use iter. meth. for finding the roots where the intial val. obtd. of randomness is in the sampling procedure: if values of Λ suggest that H_0 explains the data set vou take another sample, vou obtain a different better than H_1 , while small Λ indicates that H_1 p-value. To illustrate, suppose we are testing $H_0: \theta = \theta_0$ vs. $H_1: \theta > \theta_0$. Suppose the null • Parametric bootstrap- For initial values, we hypothesis is true. Given $z_{obs} = z$, p-value is apply m.o.m est. formula are $\hat{\alpha} = \frac{\hat{\mu}^2}{\hat{\alpha}^2} \& \hat{\lambda} = \frac{\hat{\mu}}{\hat{\alpha}^2}$ hypothesis that: $\operatorname{div}(A \cap Z_{obs}) = Z_0 \operatorname{prime}(B)$ which is $P = P(Z > z) = 1 - \phi(z)$ and in terms of the random variables $P = P(Z > Z_{obs}) = 1 - \phi(Z_{obs})$.

• Under H_0 , $P(P > p) = P(1 - \phi(Z_{obs}) > 1 - \phi(z)) = P(\phi(Z_{obs}) < \phi(z)) = P(Z_{obs} < z) = \phi(z) = 1 - p \dots P$ -value has uniform null distr.

> alternative hypotheses: 1-sided H_1 : $p > p_0$, 1-sided H_1 : $p < p_0$, 2-sided H_1 : $p \neq p_0$. Consider a parametric model for the data Alter. H_1 Rej. rule P-value $H_0:(p_1,\cdots,p_I)=(v_1(\lambda),\cdots,v_I(\lambda))$ with unknown $P(Z \ge z_{obs})$ $p > p_0$ $z \ge z_{\alpha}$ parameters $\lambda = (\lambda_1, \dots, \lambda_r)$. To see if the propo- $P(Z \leq z_{obs})$ $p < p_0$ $z \leq -z_{\alpha}$ $z \le -z_{\alpha/2}$ or $z \ge z_{\alpha/2} \mid 2P(Z \ge |z_{obs}|)$ sed model fits the data, compute $\hat{\lambda}$, the m.l.e of • Power function- Consider two simple hypo- λ , and then expected cell counts $E_i = n v_i(\tilde{\lambda})$.

mately normally distributed with parameters $(np_0, np_0(1-p_0))$. At the significance level α , the rejection region for the one-sided alternative is $\frac{X-np_0}{\sqrt{np_0(1-p_0)}} \ge z_a$. The power function of the one-sided test can be computed using the normal approximation for $\frac{X-np_1}{\sqrt{np_1(1-p_1)}}$

theses H_0 : $p = p_0 \& H_1$: $p = p_1$ assuming

 $p_1 > p_0$. The null distribution of Y is approxi-

der H_1 : $Pw(p_1) = P(\frac{X - np_0}{\sqrt{np_0(1-p_0)}} \ge z_\alpha | H_1) =$ $\frac{z_{\alpha}\sqrt{p_0(1-p_0)}+\sqrt{n}(p_0-p_1)}{m}|H_1|$

 $- \phi(\frac{z_{\alpha}\sqrt{p_0(1-p_0)}+\sqrt{n}(p_0-p_1)}{\sqrt{n}(p_0-p_1)})$, Now, since under the alternative hypothesis X

 $\phi(\frac{z_{\alpha}\sqrt{p_0(1-p_0)}+\sqrt{n}(p_0-p_1)}{p_0})$. This leads to the equation $\frac{z_{\alpha}\sqrt{p_0(1-p_0)}+\sqrt{n}(p_0-p_1)}{\sqrt{n}}$

which gives the formula for sample size $\sqrt{n} = \frac{z_{\alpha}\sqrt{p_0(1-p_0)} + z_{\beta}\sqrt{p_1(1-p_1)}}{2}$ • If the alternatives are very close to each other, the denominator tends to zero and hence the

with parameters (np_1, np_1q_1) ,

sample size becomes very large. • If we decrease the levels α and β , the values z_{α} and z_{β} from the normal distribution table

become larger and the sample size will be larger as well. If we want to have more control over both types of errors, we have to collect more 3. Small-sample test for the proportion • For small n, we use exact null distribution $X \sim$

 $Bin(n, p_0). P(X \ge x) = \sum_{i=x}^{n} {n \choose i} p_0^{j} (1 - p_0)^{n-j}$

4. Two tests for the mean · Large-sample test for mean- pop. distr. is not necessarily normal- sample size n is sufficiently

large-compute the rejection region using an approximate null distr. $T \approx^{H_0} N(0,1)$ • One-sample t-test-pop. distr. is normal-small n-compute the rejection region using an exact

 $\mu = \mu_0$ if the interval does not cover val. of μ_0 . 5. Likelihood ratio test For testing $H_0: \theta = \theta_0$ against $H_1: \theta = \theta_1$, we use likelihood ratio as test statistic- $\Lambda = \frac{L(\theta_0)}{L(\theta_1)}$. Large

explains the data set better. Likelihood ratio test rejects H_0 for small values of Λ . • Neyman-Pearson lemma: the likelihood ratio test is optimal in the case of two simple hypo-

6. Pearson's chi-squared test/Goodness of fit chi-square test Suppose that each of n indep. obs. belongs to one of J classes with prob. (p_1, \dots, p_I) .

Such data are summarised as the vector of observed counts whose joint distribution is multinomial $(O_1, \dots, O_J) \sim Mn(n; p_1, \dots, p_J)$, $P(O_1 = k_1, \dots, O_J = k_J) = \frac{n!}{k_1! \dots k_J!} p_1^{k_1} \dots p_J^{k_J}$

Chi-squared test statistic $\chi^2 = \sum_{i=1}^{J} \frac{(O_j - E_j)^{i}}{E_i}$ whose approx. null distr. is χ^2_{J-1-r} where J = no. of cells & r = no. of indep. para. estimtd. from

• Example: geometric model 7. Example: sex ratio

• Simple hypothesis $H_0: p_i = \binom{n}{i} 2^n$. $E_i = N p_i$ • Comp. hyp. $H_0: p_i = \binom{n}{i} \hat{p}^j (1-\hat{p})^{n-j}$. $E_i = N p_i$

V Bayesian inference

• Posterior distr. $h(\theta|x)$ using the Bayes formula

(Bayes Probability Law) $h(\theta|x) = \frac{f(x|\theta)g(\theta)}{\phi(x)}$ where $\phi(x) = \int f(x|\theta)g(\theta)d\theta$ or $\sum_{\theta} f(x|\theta)g(\theta)$. approximately normally distributed

p < 1 with mean and variance $\mu = \frac{a}{a+b}$, $\sigma^2 =$ 4. Bayesian hypotheses testing We consider the case of two simple hypotheses. Choose between $H_0: \theta = \theta_0 \& H_1: \theta = \theta_1$ using not only the likelihoods of the data Dirichlet distribution- Density fn. $f(x|\theta_0), f(x|\theta_1)$ but also prior probabilities $P(H_0) = \pi_0$, $P(H_1) = \pi_1$. In terms of the rejection region R the decision should be taken depending Data distr. Posterior distr. of a cost function. c_0 is the error type I cost and c_1 $N(\gamma_n \mu_0 + (1 \mu \sim N(\mu_0, \sigma_0^2)$ is the error type II cost. For a given set R, the ave- $N(\mu, \sigma^2)$ $\gamma_n(\bar{x};\gamma_n\sigma_0^2)$ rage cost is the weighted mean of two values c_0 $X \sim Bin(n, p)$ Beta(a + x, b +and c_1 is $c_0 \pi_0 P(X \in R|H_0) + c_1 \pi_1 P(X \notin R|H_1) =$ $c_1\pi_1 + \int_{\mathbb{R}} (c_0\pi_0 f(x|\theta_0) - c_1\pi_1 f(x|\theta_1)) dx$. It fol- $(X_1, \dots, X_r) \sim (p_1, \dots, p_r) \sim M n(n; p_1, \dots, p_r)$ $Dir(\alpha_1, \dots, \alpha_r)$ $Dir(\alpha_1)$ $x_1, \cdots, \alpha_r + x_r$ lows that the rejection region minimising the ave-Beta(a+n,b+ X_1, \cdots, X_n Geom(p)rage cost is $R = \{x : c_0 \pi_0 f(x|\theta_0) < c_1 \pi_1 f(x|\theta_1)\}.$ Beta(a,b)Thus the optimal decision rule becomes to $Gam(\alpha_0)$ reject H_0 for small values of the likelihood ratio $Pois(\mu)$ $n\bar{x}, \lambda_0 + n$ when $\frac{f(x|\theta_0)}{f(x|\theta_1)} < \frac{c_1\pi_1}{c_0\pi_0}$ or for small posterior odds, $Gam(\alpha_0)$ $\alpha n, \lambda_0 + n\bar{x}$ posterior pseudo-counts = prior pseudocounts plus sample counts VI Summarising data Normal-Normal model Shrinkage factor-1. Empirical probability distribution Empirical distr. fn. $\hat{F}(x) = \frac{1}{n} \sum_{i=1}^{n} 1_{\{x_i \le x\}}$. If the data describes life lengths, then it is mo- Binomial-Beta modelre convenient to use the empirical survival fn. Simple demonstration that beta distribution gives a conjugate prior to the binomial likelihood. $prior \propto p^{a-1}(1-p)^{b-1}$ greater than x. If the life length T has distr. fn. $F(t) = P(T \le t)$, then its survival function is $likelihood \propto p^{x}(1-p)^{n-x}$ posterior ∝ prior × likelihood ∝ $p^{a+x-1}(1-p)^{b+n-x-1}$. 2. Bayesian estimation In terms of decision theory, we are looking for an optimal action action a = {assignvalueatounknownparameterθ} The optimal a depends on the choice of the loss function $l(\theta, a)$. Bayes action minimises posterior risk $R(a|x) = E(l(\Theta, a)|x)$ The hazard function can be viewed as the neso that $R(a|x) = \int l(\theta, a)h(\theta|x)d\theta$ or gative of the slope of the log survival fn: h(t) = $R(a|x) = \sum_{\theta} l(\theta, a)h(\theta|x)$. There are 2 loss $-\frac{d}{dt}\ln S(t) = -\frac{d}{dt}\ln(1-F(t))$. A constant hazard fns leading to two Bayesian estimators. rate $h(t) = \lambda$ corresponds to the exponential dis-1. Zero-one loss fn and max a posteriori probabitribution $E x p(\lambda)$. Zero-one loss fn: $l(\theta, a) = 1_{\theta \neq a}$ 2. Density estimation 3. Quantiles and QQ-plots Using zero-one loss fn., the posterior risk is $R(a|x) = \sum_{\theta \neq a} h(\theta|x) = 1 - h(a|x)$. It follows that to minimise the risk we have to maximise the posterior probability. We define $\hat{\theta}_{map}$ as the dots with coordinates $(x_{(k)}, y_{(k)})$. value of θ that maximises $h(\theta|x)$. Observe that 4. Testing normality with the uninformative prior, $\hat{\theta}_{map} = \hat{\theta}_{mle}$. 2. Squared error loss function and posterior Squared error loss: $l(\theta, a) = (\theta - a)^2$ Using squared error loss function, the posterior risk is $R(a|x) = E((\Theta - a)^2|x) =$ $Var(\Theta|x) + [E(\Theta|x) - a]^2$. Since the first component is independent of a, we minimise the posterior risk by putting $\hat{\theta}_{pme} = E(\Theta|x)$. • Multinomial Dirichlet- 2 Bayesian estimates-1. Prior- $\hat{\theta}_{map} = \hat{\theta}_{mle} = (\frac{\alpha_1}{\alpha_1 + \alpha_r}, \cdots, \frac{\alpha_r}{\alpha_1 + \alpha_r})$ 2. Posterior mean estimate- $\hat{\theta}_{pme}$ 3. Credibility interval • Let x be the data. For a confidence interval formula $I_{\theta} = (a_1(x), a_2(x))$, the parameter θ is distr: β_2 < 3 (light tails). 5. Measures of location

Treating ϕ as a constant and the Bayes for- is random $P(a_1(X) < \Theta < a_2(X)) = 1 - \alpha$. A mula can be summarised as posterior \propto credibility interval $J_{\theta} = (b_1(x), b_2(x))$ is treated

likelihood×prior.

• Beta distribution- $f(p) = \frac{\Gamma(a+b)}{\Gamma(a)\Gamma(b)} p^{a-1} p^{b-1}, 0 <$

1. Conjugate priors

$\hat{S}(x) = 1 - \hat{F}(x)$, the proportion of the data

S(t) = P(T > t) = 1 - F(t). Hazard function $h(t) = \frac{f(t)}{S(t)}$ where f(t) = F(t) is the probability density fn. The hazard fn. (also known as the failure rate, hazard rate, or force of mortality) is the ratio of the probability density function to the survival fn. The hazard function is the mortality rate at age t: $P(t < T \le t + \delta | T \ge t)$ $\frac{P(t < T \le t + \delta)}{P(T \ge t)} = \frac{F(t + \delta) - F(t)}{S(t)} \sim \delta h(t), \delta \to 0.$

as a nonrandom interval, while θ is generated by

the posterior distribution of a random variable Θ .

A credibility interval is computed from the poste-

rior distribution $P(b_1(x) < \Theta < b_2(x)|x) = 1 - \alpha$.

For a given distr. F and $0 \le p \le 1$, the p-quantile is $x_p = Q(p)$. $x_{(k)}$ is called the empirical $(\frac{k-0.5}{n})$ quantile.. QQ-plot is a scatter plot of n

• Coefficient of skewness: $\beta_1 = \frac{E(X-\mu)^3}{\sigma^3}$, sample skewness: $b_1 = \frac{1}{s^3 n} \sum_{i=1}^n (x_i - \bar{x})^3$. Depending on the sign of the coefficient of skewness with distinguish between symmetric $\beta_1 = 0$, skewed to the right $\beta_1 > 0$, and skewed to the left $\beta_1 < 0$

 $b_2 = \frac{1}{s^4 n} \sum_{i=1}^n (x_i - \bar{x})^4$. Kurtosis is a measure of the peakedness of the probability distribution of a real-valued random variable, although some sources are insistent that heavy tails, and not peakedness, is what is really being measured by Kurtosis. For the normal distribution, kurtosis coefficient takes value $\beta_2 = 3$. Leptokurtic distribution: $\beta_2 > 3$ (heavy tails). Platykurtic

parametric is without the normality assumption. 6. Measures of dispersion

 $\hat{m} = \frac{x_{(k)} + x_{(k+1)}}{2}$, if n = 2k.

 $I_m = (x_{(k)}, x_{(n-k+1)})$.

median m.

 $I_m = (x_{(k)}, x_{(n-k+1)})$ is a $100p_k\%$ c.i. for the pop.

• sign test The sign test is a non-parametric

test of H_0 : $m = m_0$ against the two-sided

alternative $H_0: m \neq m_0$. The sign test statistic

 $y_0 = \sum_{i=1}^n 1_{\{x_i \le m_0\}}$ counts the number of obser-

vations below the null hypothesis value. It has

sample (x_1, \dots, x_n) . Generate many bootstrap

samples of size n to approximate the sampling

distribution for an estimator like trimmed mean,

The difference between non parametric boot-

strap and parametric bootstrap is that parame-

tric is with the normality assumption, and non

• We wish to compare 2 pop. distr. with means and std. dev. (μ_1, σ_1) , (μ_2, σ_2) based on 2

their std errors $s_{\bar{x}} = \frac{s_1}{\sqrt{n}}, s_1^2 = \frac{1}{n-1} \sum_{i=1}^{n} (x_i - \bar{x})^2$ & $s_{\bar{y}} = \frac{s_2}{\sqrt{m}}, s_2^2 = \frac{1}{m-1} \sum_{i=1}^{m} (y_i - \bar{y})^2$. Diff. $\bar{x} - \bar{y}$ is

then $Var(\bar{X} - \bar{Y}) = \sigma_{\bar{Y}}^2 + \sigma_{\bar{Y}}^2 = \frac{\sigma_1^2}{n} + \frac{\sigma_2^2}{m}$ & $s_{ar{X}-ar{Y}}^2=s_{ar{X}}^2+s_{ar{Y}}^2=rac{s_1^2}{n}+rac{s_2^2}{m}$ gives an unbiased estimate of $Var(\bar{X} - \bar{Y})$. • Large sample test for the difference between

Approximate confidence interval formula- $I_{\mu_1 - \mu_2} = \bar{x} - \bar{y} \pm z_{\alpha/2} \sqrt{s_{\bar{x}}^2 + s_{\bar{v}}^2}$ • Two-sample t-test The key assumption of the two-sample t-test: two normal pop. distr. $X \sim$

 $N(\mu_1, \sigma^2)$, $Y \sim N(\mu_2, \sigma^2)$ have equal variances. Given $\sigma_1^2 = \sigma_2^2 = \sigma^2$, the pooled sample variance $\sum_{i=1}^{n} (x_i - \bar{x})^2 + \sum_{i=1}^{m} (y_i - \bar{y})^2$

 $E(S_n^2) = \frac{n-1}{n+m-2}E(S_1^2) + \frac{m-1}{n+m-2}E(S_2^2) = \sigma^2$. In the equal variance two sample setting, the

a simple null distribution $Y_0 \sim^{H_0} Bin(n, 0.5)$. Connection to the above c.i formula: reject H_0 if m_0 falls outside the corresponding c.i. • trimmed means- α -trimmed mean \bar{x}_{α} = sample mean without $\frac{n\alpha}{2}$ smallest and $\frac{n\alpha}{2}$ largest • Nonparametric bootstrap- Substitute the population distribution by the empirical distribution. Then a bootstrap sample is obtained by resampling with replacement from the original

• Sample median $\hat{m} = x_{(k)}$, if n = 2k - 1, and variance $Var(\bar{X} - \bar{Y}) = \sigma^2 \frac{n+m}{nm}$ has the fol-

est. of p_1 & p_2 are $\hat{p}_1 = \frac{x}{n}$ & $\hat{p}_2 = \frac{y}{m}$ which have VII Comparing two samples standard errors $s_{\hat{p}_1} = \sqrt{\frac{\hat{p}_1(1-\hat{p}_1)}{n-1}} \& s_{\hat{p}_2} = \sqrt{\frac{\hat{p}_2(1-\hat{p}_2)}{m-1}}$ Large sample test for two proportions-If the samples sizes m and n are lariid-samples (x_1, \dots, x_n) and (y_1, \dots, y_m) from ge, then an approx. c.i for $p_1 - p_2$ is these 2 pop. Two sample means \bar{x} , \bar{y} and $I_{p_1-p_2} = \hat{p}_1 - \hat{p}_2 \pm 1.96 \sqrt{\frac{\hat{p}_1(1-\hat{p}_1)}{n-1} + \frac{\hat{p}_2(1-\hat{p}_2)}{m-1}}.$ We can test the null hypothesis of equality H_0 :

 $p_1 = p_2$ 3. Paired samples Fisher's exact test-Fisher's exact test deals with

an unbiased est. of $\mu_1 - \mu_2$. We are interested in finding the std. error of $\bar{x} - \bar{y}$ & an interval the null hypothesis H_0 : $p_1 = p_2$ when the sample sizes m and n are not sufficiently large for applyest. for $\mu_1 - \mu_2$ & testing the null hypothesis of equality $H_0: \mu_1 = \mu_2$.

1. Two indep. samples: comparing pop. means If (X_1, \dots, X_n) is indep. from (Y_1, \dots, Y_m) , ing normal approximations for the binomial distr. Number of succes-

Number

of failures

Sample si-

Consider I levels of the main factor A each successes x + y. Under the null hypothesis, the conditional distr. of X is hypergeometric $X \sim Hg(N, n, p)$ with parameters (N, n, p)defined by N = n + m, $p = \frac{x+y}{N}$. This is a discrete distr. with prob. mass fn. $P(X = x) = \frac{\binom{Np}{x}\binom{Nq}{n-x}}{\binom{N}{x}}$

Fisher's idea for this case, was to use X as a test

statistic conditionally on the total number of

Sample

on rule of the Fisher test. Signed rank test The sign test disregards a lot of information in the data taking into account only the sign of the differences. The signed rank test pays attention to sizes of positive and negative differences. This is a non-parametric test for the null hypothesis of no diff. H_0 : distr. of D is symmetric about its median m = 0. The null hypothesis consists of two parts: symmetry of the distr. and m = 0. Test

 $w_{-} = \sum_{i=1}^{n} rank(|d_i|).1_{d_i < 0}$. Assuming no ties, that is $d_i \neq 0$, we get $w_+ + w_- = \frac{n(n+1)}{2}$. The null distributions of W_{\perp} & W_{\perp} are the same and tabulated for smaller values of n. For n > 20. one can use the normal approximation of the null distr. with mean and var. $\mu_W = \frac{n(n+1)}{4}$ &

statistics: either $w_+ = \sum_{i=1}^n rank(|d_i|).1_{d_i>0}$ or

 t_{n+m-2} . Exact confidence interval formula $I_{\mu_1 - \mu_2} = \bar{x} - \bar{y} \pm t_{n+m-2} (\alpha/2) s_p \sqrt{\frac{n+m}{nm}}$. Two sample t-test uses the test statistic $t = \frac{\bar{x} - \bar{y}}{s_n} \sqrt{\frac{nm}{n+m}}$ $\sigma_W^2 = \frac{n(n+1)(2n+1)}{24}$. The signed rank test uses for testing $H_0:\mu_1=\mu_2$. The null distribution of more data information than the sign test but

lowing unbiased estimate $s_{\bar{x}-\bar{y}}^{2m} = s_p^2 \frac{n+m}{nm}$.

Exact distribution $\frac{(\bar{X}-\bar{Y})-(\mu_1-\mu_2)}{S_n}\sqrt{\frac{nm}{n+m}} \sim$

Rank sum test-It is a nonparametric test for

two indep, samples, which does not assume

normality of pop. distr. Assume continuous

population distributions F_1 and F_2 , and consider H_0 : $F_1 = F_2$ against H_1 : $F_1 \neq F_2$. The rank sum

test procedure: pool the samples and replace

the data values by their ranks $1, 2, \dots, n + m$

starting from the smallest sample value to the

largest, and then compute two test statistics $r_1 =$

sum of x-ranks, and r_2 = sum of y-ranks. Clearly

 $r_1 + r_2 = 1 + 2 + \dots + (n+m) = \frac{(n+m)(n+m+1)}{2}$. The

null distr. for R_1 and R_2 depend only on the

sample sizes n and m. For $n \ge 10$, $m \ge 10$, apply

the normal approximation for the null distr. of R_1

and R_2 with $E(R_1) = \frac{n(n+m+1)}{2}$, $E(R_2) = \frac{m(n+m+1)}{2}$, $Var(R_1) = Var(R_2) = \frac{mn(n+m+1)}{12}$.

2. Two indep. samples: comparing population

For $X \sim Bin(n, p_1)$, $Y \sim Bin(m, p_2)$, unbiased

Sample

VIII Analysis of variance 1-wav ANOVA A test that allows

one to make

placebo effect

dep. var. What is

being independent pared

variable variable.

of samp les

Step 3: Set up decision rule.

One-way F-test

The pooled sample var. $s_n^2 = MS_E$ is an unbiased

Step 1: Set up hypotheses and determine level of Nq=n+m-significance H_0 : $\mu_1 = \dots = \mu_I$, H_1 : Means are not $\frac{x-y}{a}$ all equal $\mu_u \neq \mu_v$, state α .

• Kurtosis $\beta_2 = \frac{E(X-\mu)^4}{\sigma^4}$, sample kurtosis:

two means- If n and m are large, we can use a normal approximation $\frac{\bar{X} - \bar{Y} - (\mu_1 - \mu_2)}{S_{\bar{X}}^2 + S_{\bar{Y}}^2} \approx N(0, 1).$ The hypothesis $H_0: \mu_1 = \mu_2$ is tested using the = whose null distribution

is approximated by the standard normal N(0,1).

is an unbiased estimate of the variance with

Variadistr. should be used for determining the rejecti-Error

 $SS_T = \sum_i \sum_j (y_{ij} - y_{ij})$ $\bar{y}_{...}$)² = $SS_A + SS_E$

comparisons comparisons between between means of 3 or means of 3 or more groups of

requires symmetric distribution of differences.

4. External and confounding factors

more groups of data, where two independent variables are considered. The effect of The means of

three or more multiple groups groups of an of two indep. variables

dependent variable and on each other. Three or more. groups

1. One-way layout

 $Y = \mu(X) + \epsilon, E(\epsilon) = 0$ Normal theory model

of sample size I. Degrees of freedom are

Np=x+y

Source | $max(0, n - Nq) \le x \le min(n, Np)$. This null

2-way ANOVA

A test that allows

dependent

Each variable should have multiple samples.

 $df_1 = I - 1 = n_1 \& df_2 = I(J - 1) = n_2$. Critical value F_{n_1,n_2} can be found from F distr. table. Decision rule is: Reject H_0 if $F > F_{n_1,n_2}$. Step 4. Compute the test statistic. One-way Anova table. Sums of Squares | Deg. | Mean

 $SS_A = J \sum (\bar{y}_{i.} -$

 $MS_E =$

2. Simultaneous confidence interval

 $Y_{ij} = \mu + \alpha_i + \epsilon_{ij}, \sum_i \alpha_i = 0, \epsilon_{ij} \sim N(0, \sigma^2).$ Using the maximum likelihood approach, the point estimates are $\hat{\mu} = \bar{y}_{..}$, $\hat{\mu}_i = \bar{y}_i$, $\hat{\alpha}_i = \bar{y}_i - \bar{y}_{..}$ where $\bar{y}_{i.} = \frac{1}{I} \sum_{i} y_{ij} \& \bar{y}_{..} = \frac{1}{I} \sum_{i} y_{i.}$. It follows that $y_{ij} = \hat{\mu} + \hat{\alpha}_i + \hat{\epsilon}_{ij}, \hat{\epsilon}_{ij} = y_{ij} - \bar{y}_{i,j}, \sum_{i=1}^{I} \hat{\alpha}_i = 0$

Step 2: Select the appropriate test statistic.

The test statistic is the F statistic for Anova,

Free-

 $MS_A = F = \frac{MS_A}{MS_F}$

 $\frac{SS_A}{df_A}$

 $100(1-\alpha)\%$ simultaneous c.i. for a single pair of Here, $SS_A = JK\sum_i(\bar{y}_{i,..} - \bar{y}_{...})^2 \& SS_B$ $IK\sum_{i}(\bar{y}_{.j.} - \bar{y}_{...})^{2} \& SS_{A*B} = K\sum_{i}\sum_{i}(\bar{y}_{ij.} - \bar{y}_{...})^{2}$ indep. samples $I_{\mu_u-\mu_v} = \bar{y}_u - \bar{y}_v \pm t_{df}(\frac{\alpha}{2})s_p\sqrt{\frac{2}{J}}$. The multiple comparison problem: the above $\bar{y}_{i..} - \dot{\bar{y}}_{i..} + \bar{y}_{...}^2 \& SS_E = \sum (y_i - \bar{y}_{ij})^2$ confidence interval formula is aimed at a single The mean sums of squares and their expected difference, and may produce false discoveries.

Bonferroni method

Tukey method

3. Kruskal-Wallis test

4. Two-way layout

the grand mean,

 $\& \sum_{i=1}^{J} \delta_{ij} = 0$

Normal theory model

 $\delta_{ij} = \bar{y}_{ij.} - \bar{y}_{i..} - \bar{y}_{.j.} + \bar{y}_{...}$

Source SS df

Main Effect A

Main Effect B

Error

Bonferroni method is a statistical test repeatedly

applied to k independent samples of size n. The

 $B_{\mu_u - \mu_v} = \bar{y}_u - \bar{y}_v \pm t_{df}(\frac{\alpha}{2k}) s_p \sqrt{\frac{2}{7}}, 1 \le u < v \le I$

where df = I(J-1) and $k = \frac{I(I-1)}{2}$. Bonferroni

are equal in distribution. Extending the idea

of the rank-sum test, consider the pooled sample of size N = IJ. Let r_{ij} be the poo-

led ranks of the sample values y_{ij} , so that

 $\sum_{i} \sum_{j} r_{ij} = 1 + 2 + ... + N = \frac{N(N+1)}{2}$ where the

mean rank is $\bar{r}_{...} = \frac{(N+1)}{2}$. Kruskal-Wallis test

statistic is given by $W = \frac{12J}{N(N+1)} \hat{\sum} (\bar{r}_{i.} - \frac{N+1}{2})^2$

Reject H_0 for large W using the null distribution table.

 $\mu(x_{1i}, x_{2j}) = \mu_{ij} = \mu + \alpha_i + \beta_j + \delta_{ij}$ where μ is

 δ_{ij} is the AB-interaction effect, with $\sum_{i=1}^{I} \delta_{ij} = 0$

 $Y_{ijk} = \mu + \alpha_i + \beta_j + \delta_{ij} + \epsilon_{ijk}, i = 1, \dots, I, j = 0$

 $\hat{\epsilon}_{ijk} = y_{ijk} - \bar{y}_{ij.}$. Three F-tests-

 $\frac{SS_B}{df_B}$

 $1, \dots, J, k = 1, \dots, K$ where $\epsilon_{i,i,k} \sim N(0, \sigma^2)$

IJ(K-1)

 α_i is the main A-effect, $\sum_{i=1}^{I} \alpha_i = 0$

 β_j is the main B-effect, $\sum_{j=1}^{J} \beta_j = 0$

values $E(MS_A) = \sigma^2 + \frac{JK}{I-1} \sum_i \alpha_i^2$ $E(MS_B) = \sigma^2 + \frac{IK}{I-1} \sum_i \beta_i^2$

 $E(MS_{AB}) = \sigma^2 + \frac{K}{(I-1)(I-1)} \sum_{i} \sum_{i} \delta_{i,i}^2$ overall significance level α is obtained, if each single test is performed at significance level $E(MS_F) = \sigma^2$ $\alpha_0 = \alpha/k$. Assuming the null hypothesis is true, 6. Randomised block design the number of positive results is $X \sim Bin(k, \alpha_0)$. Blocking is used to remove the effects of the most Thus for small values of α_0 , $P(X \ge 1 \mid H_0) =$ important nuisance variable. Randomisation is $1-(1-\alpha_0)^k \approx k\alpha_0 = \alpha$. This gives Bonferroni's $100(1-\alpha)\%$ simultaneous confidence interval

then used to reduce the contaminating effects of the remaining nuisance variables. Experimental design: randomly assign I treat ments within each of J blocks. Test the null hypothesis of no treatment effect using the two-way layout Anova. The block effect is anticipated and is not of

method gives slightly wider intervals compared to the Tukey method. major interest. Additive model If I independent samples $(y_{i1},...,y_{iJ})$ taken Mean from $N(\mu_i, \sigma^2)$ have the same size J, then of Free-Sqs. (MS) Varia- $Z_i = \bar{Y}_{i.} - \mu_i \sim N(0, \frac{\sigma^2}{I})$ are independent. dom Consider the range of differences between Z_i : $R = max\{Z_1,...,Z_I\} - min\{Z_1,...,Z_I\}$. The normalised range has a distribution that is free from $F = \frac{MS_A}{MS_E}$ Main $SS_A = J \sum_i (\bar{y}_i)$ I-1 MS_A $\frac{SS_A}{df_A}$ $MS_B =$ $F = \frac{MS_B}{MS_E}$ the parameter $\sigma \frac{R}{S_n \sqrt{J}} \sim SR(I, df), df = I(J-1).$ Main $SS_B = I \sum_i (\bar{y}_{.i} -$ I-1 $\frac{SS_B}{df_B}$ Tukey's $100(1-\alpha)\%$ simultaneous confidence in-Error $SS_E = \sum_i \sum_j (y_{ij})$ MS_E terval is given by $T_{\mu_u-\mu_v} = \bar{y}_{u.} - \bar{y}_{v.} \pm q_{I,df}(\alpha) \frac{s_p}{\sqrt{I}}$. $\frac{SS_E}{df_E}$ A nonparametric test, without assuming norma- $SS_T = \sum_i \sum_j (\bar{y}_{ij})$ $\bar{y}_{SS}^{(1)} = SS_A + SS_A +$ lity, for no treatment effect H_0 : all observations

 $E(MS_A) = \sigma^2 + \frac{J}{J-1} \sum_i \alpha_i^2$

 $E(MS_F) = \sigma^2$

7. Friedman test

 $E(MS_B) = \sigma^2 + \frac{I}{I-1} \sum_i \beta_i^2$

Here we introduce another nonparametric test, which does not require that $\hat{\epsilon}$ ij are normally distributed, for testing H_0 : no treatment effect. The Friedman test is based on within block ranking. Let ranks within j-th block be: (r_{ij}, \dots, r_{Ij}) =ranks of (r_{ij}, \dots, r_{Ij}) so that $r_{1j} + \dots + r_{Ij} = 1 + 2 + \dots + I = \frac{I(I+1)}{2}$ where $\frac{1}{I}(r_{1,i} + \dots + r_{I,i}) = \frac{I+1}{2}$ and $\bar{r}_{i} = \frac{(I+1)}{2}$. Friedman

IX Categorical data analysis 1. Chi-squared test of homogeneity

approximate null distribution $Q \sim \chi_{I-1}^2$ Reject

 H_0 for large W using the null distribution table.

Consider a table of $I \times J$ observed counts obtd. from J indep. samples taken from J pop. distr.: Pop. 1 Pop. 2 · · · Pop. J

Category I	n	12		и	n.	OI
Category I Sample sizes	n_{I1}	n_{I2}				or
					$n_{I.}$	wl
This model is described by J multinomial dis-						
tr. $(N_{1j}, \dots, N_{1j}) \sim M n(n_{.j}; \pi_{1 j}, \dots, \pi_{I j}), j =$						
						re
$1, \dots, J$ Under the hypothesis of homogeneity						th
$H_0: \pi_{i j} = \pi_i, \forall (i,j), \text{ the m.l.e of } \pi_i \text{ are the}$						1.
pooled sample proportions $\hat{\pi_i} = \frac{n_i}{n}$, $i = 1, \dots, I$.						A
Using m.l.e, we compute the expected cell						ra
						ar
counts E_{ij}	- 10	÷ _ '	$n_{i.}n_{.j}$;	_ 1	T	
counts E_{ij}	$-n_{.j}$	ι_i –	${n_{}}$, ι	- 1,	,1	Y
& the chi-	-squared	l test	statistic	beco	omes	no

 $\chi^2 = \sum_{i=1}^{I} \sum_{j=1}^{J} \frac{(n_{ij} - n_{i.} n_{i.} / n_{..})^2}{n_{i.} n_{i.} / n_{..}}$ We reject H_0 for large values of $\chi^2 \& df = (I-1)(J-1)$. 2. Chi-squared test of independence Data: a single cross-classifying sample is sum-

marised in terms of the observed counts, whose joint distribution is multinomial $(N_{1j}, \dots, N_{1j}) \sim$ $Mn(n_{ij}; \pi_{1|ij}, \dots, \pi_{I|ij}), j = 1, \dots, J$ Under the hypothesis of homogeneity $H_0: \pi_{i|j} = \pi_i, \forall (i, j),$ the m.l.e of π_i are the pooled sample proportions $\hat{\pi_i} = \frac{n_i}{n}, i = 1, \dots, I$. Using m.l.e, we compute the expected cell counts $E_{ij} = n_{.j} \hat{\pi}_i = \frac{n_{i.} n_{.j}}{n}, i = 1, \dots, I \& \text{the chi-squared}$

sample correlation coefficient is $r = \frac{s_{xy}}{s_x s_y}$ $s_{xy} = \frac{1}{n-1} \sum (x_i - \bar{x})(y_i - \bar{y}).$ 2. Residuals Then the size of noise (estimated σ^2) is

 $s^2 = \frac{n-1}{n-2} s_v^2 (1-r^2).$ Decomposition: $y_i - \bar{y} = \hat{y}_i - \bar{y} + \hat{e}_i$ implies $SS_T = SS_R + SS_E$ $SS_T = \sum_i (y_i - \bar{y})^2 = (n-1)s_y^2$ $SS_R = \sum_i (\hat{y}_i - \bar{y})^2 = (n-1)b_1^2 s_r^2$ $SS_E = S(b_0, b_1) = \sum_i (y_i - \hat{y}_i)^2 = (n-1)s_v^2(1-r^2).$

distribution plot for the standardised residuals

Combining them, $r^2 = \frac{SS_R}{SS_T} = 1 - \frac{SS_E}{SS_T}$. Thus the 3. Matched-pairs designs McNemar's test squared sample correlation coefficient r^2 is obtd. matched-Consider data by called the coefficient of determination. Coeffifor design pop. cient of determination r^2 is the proportion of unaffected X unaffected \bar{X} Total variation in the response variable explained by the variation of the predictor. r^2 is independent

test statistic becomes $\chi^2 = \sum_{i=1}^I \sum_{j=1}^J \frac{(n_{ij} - n_{i.} n_{i.}/n_{..})^2}{n_{i.} n_{i.}/n_{..}}$

We reject H_0 for large values of χ^2 & df = (I-1)(J-1).

Null hypothesis H_0 : $p_{12} = p_{21} = p$ This yields the McNemar's test statistic: $\chi^2 = \frac{(m_{12} - m_{21})^2}{m_{12} + m_{21}}$ whose approx. null distr. is γ_1^2 4. Odds ratios

Conditional odds for A given B are de-

fined as $odds(A|B) = \frac{P(A|B)}{P(\bar{A}|B)}$

Odds ratio for a pair of events defined by $\Delta_{AB} = \frac{odds(A|B)}{odds(A|\tilde{B})} = \frac{P(AB)P(\tilde{A}\tilde{B})}{P(\tilde{A}B)P(\tilde{A}\tilde{B})}$. The odds ratio is a measure of dependence between a pair of random events having the following properties if $\Delta_{AB} = 1$, then events A and B are independent, if $\Delta_{AB} > 1$, then $P(A|B) > P(A|\bar{B})$ & so B inc. Exact $100(1-\alpha)\%$ c.i. $I_{\beta_i} = b i \pm t_{n-2}(\frac{\alpha}{2})s_{b_i}$.

if $\Delta_{AB} < 1$, then $P(A|B) < P(A|\bar{B})$ & so B dec. prob. of A. Odds ratios for case-control studies Conditional probabilities-

Total

P(X|D) $P(\bar{X}|D)$ $P(X|\bar{D})$ $P(\bar{X}|\bar{D})$ $\frac{P(X|D)P(\bar{X}|\bar{D})}{P(\bar{X}|D)P(X|\bar{D})}$ Corresponding odds ratio Δ_{DX} = • Observed counts-

Total n_{11} n_{12} n_{1} n_{22}

X Multiple regression

Corresponding odds ratio $\hat{\Delta}_{DX} = \frac{n_{11} n_{22}}{n_{12} n_{21}}$

 Simple linear regression has only one x and one y variable. Multiple linear regression has ne v and two or more x variables. For instance, when we predict rent based on square feet alone nat is simple linear regression. When we predict ent based on square feet and age of the building nat is an example of multiple linear regression. Simple linear regression model simple linear regression model connects two andom vars (X,Y): X is called predictor variable nd Y is called response by a linear relation

that has a normal distribution $N(0, \sigma^2)$ indep. of $y_n = \beta_0 + \beta_1 x_{n,1} + \dots + \beta_{p-1} X_{n,p-1} + e_n$ X. This assumption is called homoscedasticity, meaning that the noise size σ is the same for all possible levels of the predictor var. The fitted regression line is $y = b_0 + b_1 x = \bar{y} + r \frac{s_y}{s_x} (x - \bar{x})$ where

 $1 x_{n,1} \cdots x_{n,p-1}$ An unbiased estimate of σ^2 is $s^2 = \frac{SS_E}{n-p}$ where $SS_E = ||\hat{e}||^2 = ||y - \hat{y}||^2$. To check the underlying normality assumption inspect the normal probability plot for the standardised residuals $\frac{\hat{e}_i}{s\sqrt{1-p_{ii}}}$ where p_{ii} are the

Design matrix

 $1 \ x_{1,1} \cdots x_{1,p-1}$

diagonal elements of P. Coefficient of multiple determination $R^2 = 1 - \frac{SS_E}{SS_T}$, $SS_T = (n-1)s_v^2$. Adjusted coefficient of multiple determination

 $R_a^2 = 1 - \frac{n-1}{n-p} \frac{SS_E}{SS_T} = 1 - \frac{s^2}{s_E^2}$. The adjustment factor $\frac{n-1}{n-p}$ gets larger for the larger values of predictors p.

Basic probability theory • Cumulative distribution function $F(x) = P(X \le x) = \sum_{y \le x} f(y) o r = \int_{y \le x} f(y) dy$

• Expected value (mean or average) of X of choice of the explanatory and the response $\mu = E(X) = \sum_{x} f(x) \circ r = \int_{x} f(x) dx$ • $Var(cX) = c^2 Var(X)$ To test the normality assumption, use the normal

• $Var(\overline{X}) = E(\overline{X}^2) - (E(\overline{X}))^2$ • Standard normal distribution $Z \sim N(0,1)$

 $ilde{e}_i = rac{\hat{e}_i}{s_i}$, $i=1,\cdots$, n where $s_i = s\sqrt{1-rac{\sum_k (x_k-x_i)^2}{n(n-1)s^2}}$. has the density fn. and distribution For simple linear regression model, scatter plot

fn. $\phi(z) = \frac{1}{\sqrt{2\pi}}e^{-z^2/2} = \frac{1}{\sqrt{2\pi}}e^{-(\frac{X-\mu}{\sigma})^2/2}$, of the standardised residuals versus x_i should

look as a horizontal blur. Non-linearity problem $\phi(z) = \int_{-\infty}^{z} \phi(x) dx$ • Normal distribution $X \sim N(\mu, \sigma^2)$:

is fixed by log-log transformation of the data. 3. Confidence intervals and hypothesis testing $\frac{X-\mu}{\sigma} \sim N(0,1), \ f(x) = \frac{1}{\sigma} \phi(\frac{x-\mu}{\sigma}), \ E(X) = \mu,$ $i = 0, 1, B_i \sim N(\beta_i, \sigma_i^2), \quad s_{b_i}^2 = \frac{s^2 \sum x_i^2}{n(n-1)s_x^2}$

• Discrete uniform distribution $X \sim U(N)$: $f(k) = \frac{1}{N}, 1 \le k \le N, E(X) = \frac{N+1}{2}, Var(X) =$

• Continuous uniform distribution $X \sim U(a, b)$: $f(k) = \frac{1}{b-a}, a < x < b, E(X) = \frac{a+b}{2}, Var(X) =$

• Binomial distribution $X \sim Bin(n, p)$:

 $f(k) = \binom{n}{k} p^k (1-p)^{n-k}, 0 \le k \le n, E(X) =$ np, Var(X) = np(1-p)• Bernoulli distribution Ber(p) = Bin(1, p)val corresponds to an interval which the mean

• Geometric distribution $X \sim Geom(p)$: $f(k) = pq^{k-1}, k \ge 1, E(X) = \frac{1}{p}, Var(X) = \frac{1-p}{p^2}$

• Exponential distribution $X \sim E x p(\lambda)$:

 $f(k) = \frac{\lambda^k}{k!} e^{-\lambda}, k \le 0, E(X) = Var(X) = \lambda$

• Poisson distr. $X \sim Pois(\lambda)$:

 $f(x) = \lambda e^{-\lambda x}, x > 0, E(X) = \sigma_X = \frac{1}{\lambda}$

The two-sample t-test assumes that two inde-

taken from two normal distributions with equal variance. To test this normality assumption

one may use a normal probability plot for n+m residuals $X_1 - \bar{X}, \dots, X_n - \bar{X}, Y_1 - \bar{Y}, \dots, Y_m - \bar{Y}$). Without taking account of multiple comparisons the CI is much narrower producing an excess of

false positive results.

 $\frac{B_i - \beta_i}{S_{B_i}} \sim t_{n-2}$.

Test statistic $t = \frac{b_i - \beta i}{s_b}$ that has the exact null 4. Intervals for individual observations • In cases where we assume a model with an explanatory variable X and a response variable Y.

the prediction interval is an interval in which a single sample of Y falls with a certain probability for a given X. In this context, a confidence inter-

of Y for a given X falls with a certain probability. Thus the prediction interval is always wider than the confidence interval for a given signficance

Exact confidence interval $I_{\mu} = b_0 + b_1 x \pm$ $t_{n-2}(\frac{\alpha}{2})s\sqrt{\frac{1}{n}+\frac{1}{n-1}(\frac{x-\bar{x}}{s_x})^2}$

Exact prediction interval $I_{tt} = b_0 + b_1 x \pm b_2$ $t_{n-2}(\frac{\alpha}{2})s\sqrt{1+\frac{1}{n}+\frac{1}{n-1}(\frac{x-\bar{x}}{s_x})^2}$

Prediction interval has wider limits since it contains the uncertainty due the noise factors: $Var(Y - \hat{\mu}) = Var(\mu + \epsilon - \hat{\mu}) = \sigma^2 + Var(\hat{\mu}) =$

 $\sigma^2(1+\frac{1}{n}+\frac{1}{n-1}(\frac{x-\bar{x}}{s_x})^2)$ 5. Linear regression and ANOVA

6. Multiple linear regression Multiple linear regression model: Y = $\beta_0 + \beta_1 X_1 + \dots + \beta_{p-1} X_{p-1} + \epsilon, \ \epsilon \sim N(0, \sigma^2)$ Corr. data set consists of n indep. vectors with

n > p is $= \beta_0 + \beta_1 X + \epsilon$, $\epsilon \sim N(0, \sigma^2)$ where ϵ is the $y_1 = \beta_0 + \beta_1 x_{1,1} + \dots + \beta_{p-1} X_{1,p-1} + e_1$ oise. The key assumption of the model requires

the three different experiments.

external factors are more or less the same across

can be justified in the case when the noise value is the sum of many independent and relatively small factors. Equal variance is realistic if the

Multiple regression-The normality assumption